

IGBT Chip in NPT-technology

FEATURES:

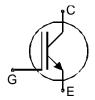
- 1200V NPT technology 175µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- · easy paralleling
- integrated gate resistor

This chip is used for:

• IGBT Modules

Applications:

• drives, SMPS, resonant applications



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC156T120R2CS	1200V	100A	12.59 X 12.59 mm ²	sawn on foil	Q67050- A4085-A003

MECHANICAL PARAMETER:

Raster size	12.59 X 12.59				
Emitter pad size	8 x (3.98 x 2.38)				
Gate pad size	1.46 x 0.8				
Area total / active	158.5 / 132.6				
Thickness	175	μm			
Wafer size	150	mm			
Flat position	90	grd			
Max.possible chips per wafer	82 pcs				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm Al Si 1%				
Collector metallization 1400 nm Ni Ag –system suitable for epoxy and soft solder die bor					
Die bond	electrically conductive glue or solder				
Wire bond	AI, <500μm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	300	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_i =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit	
i arameter	Symbol	Conditions	min.	typ.	max.	J	
Collector-emitter breakdown voltage	V _{(BR)CES}	V _{GE} =0V , I _C =5mA	1200				
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =100A	2.7	3.2	3.7	V	
Gate-emitter threshold voltage	V _{GE(th)}	I _C =4mA , V _{GE} =V _{CE}	4.5	5.5	6.5		
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V , V _{GE} =0V			600	μA	
Gate-emitter leakage current	I_{GES}	V _{CE} =0V , V _{GE} =20V			600	nA	
Integrated gate resistor	R _{Gint}			5	7	Ω	

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiametei	Symbol	Conditions	min.	typ.	max.	Oilit
Input capacitance	Ciss	V _{CE} =25V,	-	6.5		nF
Output capacitance	Coss	$V_{GE}=0V$,	-	1		
Reverse transfer capacitance	Crss	f=1MHz	-	0.5		

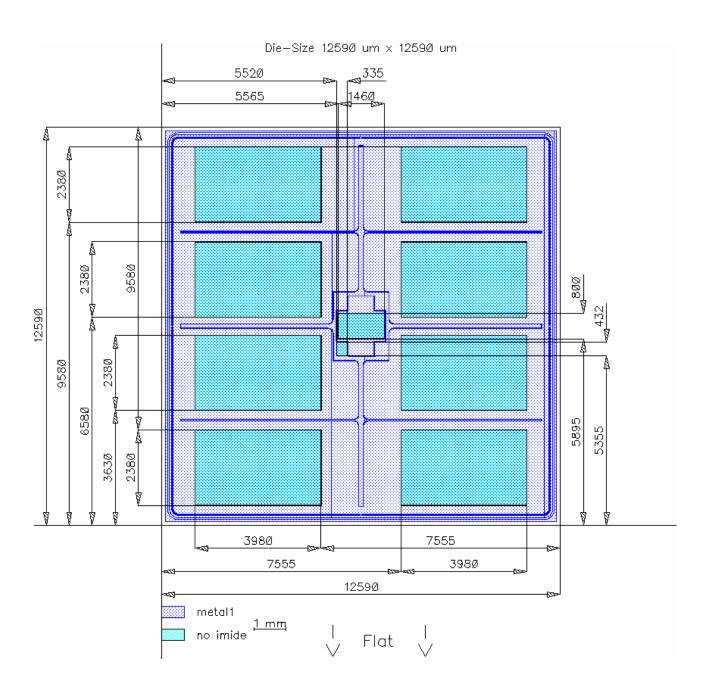
SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions 1)	Value			Unit
- arameter	Syllibol	Conditions	min.	typ.	max.	Onne
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =125°C	1	tbd		ns
Rise time	$t_{\rm r}$	V _{CC} =600V,	1	tbd		
Turn-off delay time	$t_{d(off)}$	I _C =100A, V _{GE} =-15/15V,	ı	tbd		
Fall time	t_{f}	$R_{\rm G}$ = Ω	-	tbd		

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	tbd				
DESCRIPTION:					
AQL 0,65 for visual inspection according to failure catalog					
Electrostatic Discharge Sensitive Device according to MIL-STD 883					
Test-Normen Villach/Prüffeld					

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